

<b>Notice of References Cited</b>	Application/Control No. 10/664,477		Applicant(s)/Patent Under Reexamination OBRADOVICH, MICHAEL L.	
	Examiner Eric M Gibson		Art Unit 3661	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,483,441	11-2002	Hinde, Thomas F.	340/932.2
	B	US-6,157,294	12-2000	Urai et al.	340/436
	C	US-5,767,793	06-1998	Agravante et al.	340/903
	D	US-5,642,093	06-1997	Kinoshita et al.	340/439
	E	US-5,583,495	12-1996	Ben Lulu, Dani	340/904
	F	US-5,432,509	07-1995	Kajiwarra, Yasuya	340/903
	G	US-5,347,273	09-1994	Katiraie, Kamyar	340/903
	H	US-5,014,200	05-1991	Chundrlik et al.	701/96
	I	US-4,692,764	09-1987	Bonar, George D.	342/71
	J	US-4,670,845	06-1987	Etoh, Yoshiyuki	701/301
	K	US-4,240,152	12-1980	Duncan et al.	367/108
	L	US-4,103,278	07-1978	Satake et al.	367/107
	M	US-3,796,864	03-1974	Sampey, Harry R.	377/24

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.